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What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	ARM® Cortex®-M7
Core Size	32-Bit Single-Core
Speed	480MHz
Connectivity	CANbus, EBI/EMI, Ethernet, I ² C, IrDA, LINbus, MDIO, MMC/SD/SDIO, QSPI, SAI, SPDIF, SPI, SWPMI, UART/USART, USB OTG
Peripherals	Brown-out Detect/Reset, DMA, I ² S, LCD, POR, PWM, WDT
Number of I/O	140
Program Memory Size	2MB (2M x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	1M x 8
Voltage - Supply (Vcc/Vdd)	1.62V ~ 3.6V
Data Converters	A/D 36x16b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	201-UFBGA
Supplier Device Package	176+25UFBGA (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm32h753iik6

3.3 Memories

3.3.1 Embedded Flash memory

The STM32H753xI devices embed up to 2 Mbytes of Flash memory that can be used for storing programs and data.

The Flash memory is organized as 266-bit Flash words memory that can be used for storing both code and data constants. Each word consists of:

- One Flash word (8 words, 32 bytes or 256 bits)
- 10 ECC bits.

The Flash memory is divided into two independent banks. Each bank is organized as follows:

- A 1-Mbyte user Flash memory block containing eight user sectors of 128 Kbytes (4 K Flash words)
- 128 Kbytes of System Flash memory from which the device can boot
- 2 Kbytes (64 Flash words) of user option bytes for user configuration

3.3.2 Secure access mode

In addition to other typical memory protection mechanism (RDP, PCROP), STM32H753xI devices introduce the Secure access mode, a new enhanced security feature. This mode allows developing user-defined secure services by ensuring, on the one hand code and data protection and on the other hand code safe execution.

Two types of secure services are available:

- STMicroelectronics Root Secure Services:
These services are embedded in System memory. They provide a secure solution for firmware and third-party modules installation. These services rely on cryptographic algorithms based on a device unique private key.
- User-defined secure services:
These services are embedded in user Flash memory. Examples of user secure services are proprietary user firmware update solution, secure Flash integrity check or any other sensitive applications that require a high level of protection.
The secure firmware is embedded in specific user Flash memory areas configured through option bytes.

Secure services are executed just after a reset and preempt all other applications to guarantee protected and safe execution. Once executed, the corresponding code and data are no more accessible.

The above secure services are available only for Cortex[®]-M7 core operating in Secure access mode. The other masters cannot access the option bytes involved in Secure access mode settings or the Flash secured areas.

The boot loader is located in non-user System memory. It is used to reprogram the Flash memory through a serial interface (USART, I2C, SPI, USB-DFU). Refer to *STM32 microcontroller System memory Boot mode* application note (AN2606) for details.

3.5 Power supply management

3.5.1 Power supply scheme

STM32H53xI power supply voltages are the following:

- V_{DD} = 1.62 to 3.6 V: external power supply for I/Os, provided externally through V_{DD} pins.
- V_{DDLDO} = 1.62 to 3.6 V: supply voltage for the internal regulator supplying V_{CORE}
- V_{DDA} = 1.62 to 3.6 V: external analog power supplies for ADC, DAC, COMP and OPAMP.
- $V_{DD33USB}$ and $V_{DD50USB}$:
 $V_{DD50USB}$ can be supplied through the USB cable to generate the $V_{DD33USB}$ via the USB internal regulator. This allows supporting a V_{DD} supply different from 3.3 V.
 The USB regulator can be bypassed to supply directly $V_{DD33USB}$ if $V_{DD} = 3.3$ V.
- V_{BAT} = 1.2 to 3.6 V: power supply for the V_{SW} domain when V_{DD} is not present.
- V_{CAP} : V_{CORE} supply voltage, which values depend on voltage scaling (0.7 V, 0.9 V, 1.0 V, 1.1 V or 1.2 V). They are configured through VOS bits in PWR_D3CR register.
 The V_{CORE} domain is split into the following power domains that can be independently switch off.
 - D1 domain containing some peripherals and the Cortex[®]-M7 core.
 - D2 domain containing a large part of the peripherals.
 - D3 domain containing some peripherals and the system control.

During power-up and power-down phases, the following power sequence requirements must be respected (see [Figure 2](#)):

- When V_{DD} is below 1 V, other power supplies (V_{DDA} , $V_{DD33USB}$, $V_{DD50USB}$) must remain below $V_{DD} + 300$ mV.
- When V_{DD} is above 1 V, all power supplies are independent.

During the power-down phase, V_{DD} can temporarily become lower than other supplies only if the energy provided to the microcontroller remains below 1 mJ. This allows external decoupling capacitors to be discharged with different time constants during the power-down transient phase.

3.28 Cryptographic acceleration (CRYPT and HASH)

The devices embed a cryptographic processor that supports the advanced cryptographic algorithms usually required to ensure confidentiality, authentication, data integrity and non-repudiation when exchanging messages with a peer:

- Encryption/Decryption
 - DES/TDES (data encryption standard/triple data encryption standard): ECB (electronic codebook) and CBC (cipher block chaining) chaining algorithms, 64-, 128- or 192-bit key
 - AES (advanced encryption standard): ECB, CBC, GCM, CCM, and CTR (Counter mode) chaining algorithms, 128, 192 or 256-bit key
- Universal HASH
 - SHA-1 and SHA-2 (secure HASH algorithms)
 - MD5
 - HMAC

The cryptographic accelerator supports DMA request generation.

3.29 Timers and watchdogs

The devices include one high-resolution timer, two advanced-control timers, ten general-purpose timers, two basic timers, five low-power timers, two watchdogs and a SysTick timer.

All timer counters can be frozen in Debug mode.

[Table 5](#) compares the features of the advanced-control, general-purpose and basic timers.

Table 5. Timer feature comparison

Timer type	Timer	Counter resolution	Counter type	Prescaler factor	DMA request generation	Capture/compare channels	Complementary output	Max interface clock (MHz)	Max timer clock (MHz) ⁽¹⁾
High-resolution timer	HRTIM1	16-bit	Up	/1 /2 /4 (x2 x4 x8 x16 x32, with DLL)	Yes	10	Yes	400	400
Advanced-control	TIM1, TIM8	16-bit	Up, Down, Up/down	Any integer between 1 and 65536	Yes	4	Yes	100	200

3.31 Inter-integrated circuit interface (I2C)

STM32H753xI devices embed four I²C interfaces.

The I²C bus interface handles communications between the microcontroller and the serial I²C bus. It controls all I²C bus-specific sequencing, protocol, arbitration and timing.

The I2C peripheral supports:

- I²C-bus specification and user manual rev. 5 compatibility:
 - Slave and Master modes, multimaster capability
 - Standard-mode (Sm), with a bitrate up to 100 kbit/s
 - Fast-mode (Fm), with a bitrate up to 400 kbit/s
 - Fast-mode Plus (Fm+), with a bitrate up to 1 Mbit/s and 20 mA output drive I/Os
 - 7-bit and 10-bit addressing mode, multiple 7-bit slave addresses
 - Programmable setup and hold times
 - Optional clock stretching
- System Management Bus (SMBus) specification rev 2.0 compatibility:
 - Hardware PEC (Packet Error Checking) generation and verification with ACK control
 - Address resolution protocol (ARP) support
 - SMBus alert
- Power System Management Protocol (PMBus™) specification rev 1.1 compatibility
- Independent clock: a choice of independent clock sources allowing the I2C communication speed to be independent from the PCLK reprogramming.
- Wakeup from Stop mode on address match
- Programmable analog and digital noise filters
- 1-byte buffer with DMA capability

3.32 Universal synchronous/asynchronous receiver transmitter (USART)

STM32H753xI devices have four embedded universal synchronous receiver transmitters (USART1, USART2, USART3 and USART6) and four universal asynchronous receiver transmitters (UART4, UART5, UART7 and UART8). Refer to [Table 6](#) for a summary of USARTx and UARTx features.

These interfaces provide asynchronous communication, IrDA SIR ENDEC support, multiprocessor communication mode, single-wire Half-duplex communication mode and have LIN Master/Slave capability. They provide hardware management of the CTS and RTS signals, and RS485 Driver Enable. They are able to communicate at speeds of up to 12.5 Mbit/s.

USART1, USART2, USART3 and USART6 also provide Smartcard mode (ISO 7816 compliant) and SPI-like communication capability.

The USARTs embed a Transmit FIFO (TXFIFO) and a Receive FIFO (RXFIFO). FIFO mode is enabled by software and is disabled by default.

3.41 Universal serial bus on-the-go high-speed (OTG_HS)

The devices embed two USB OTG high-speed (up to 480 Mbit/s) device/host/OTG peripheral. OTG-HS1 supports both full-speed and high-speed operations, while OTG-HS2 supports only full-speed operations. They both integrate the transceivers for full-speed operation (12 Mbit/s) and are able to operate from the internal HSI48 oscillator. OTG-HS1 features a UTMI low-pin interface (ULPI) for high-speed operation (480 Mbit/s). When using the USB OTG-HS1 in HS mode, an external PHY device connected to the ULPI is required.

The USB OTG HS peripherals are compliant with the USB 2.0 specification and with the OTG 2.0 specification. They have software-configurable endpoint setting and supports suspend/resume. The USB OTG controllers require a dedicated 48 MHz clock that is generated by a PLL connected to the HSE oscillator.

The main features are:

- Combined Rx and Tx FIFO size of 4 Kbytes with dynamic FIFO sizing
- Supports the session request protocol (SRP) and host negotiation protocol (HNP)
- 9 bidirectional endpoints (including EP0)
- 16 host channels with periodic OUT support
- Software configurable to OTG1.3 and OTG2.0 modes of operation
- USB 2.0 LPM (Link Power Management) support
- Battery Charging Specification Revision 1.2 support
- Internal FS OTG PHY support
- External HS or HS OTG operation supporting ULPI in SDR mode (OTG_HS1 only)

The OTG PHY is connected to the microcontroller ULPI port through 12 signals. It can be clocked using the 60 MHz output.

- Internal USB DMA
- HNP/SNP/IP inside (no need for any external resistor)
- For OTG/Host modes, a power switch is needed in case bus-powered devices are connected

3.42 Ethernet MAC interface with dedicated DMA controller (ETH)

The devices provide an IEEE-802.3-2002-compliant media access controller (MAC) for ethernet LAN communications through an industry-standard medium-independent interface (MII) or a reduced medium-independent interface (RMII). The microcontroller requires an external physical interface device (PHY) to connect to the physical LAN bus (twisted-pair, fiber, etc.). The PHY is connected to the device MII port using 17 signals for MII or 9 signals for RMII, and can be clocked using the 25 MHz (MII) from the microcontroller.

The devices include the following features:

- Supports 10 and 100 Mbit/s rates
- Dedicated DMA controller allowing high-speed transfers between the dedicated SRAM and the descriptors
- Tagged MAC frame support (VLAN support)
- Half-duplex (CSMA/CD) and full-duplex operation
- MAC control sublayer (control frames) support
- 32-bit CRC generation and removal
- Several address filtering modes for physical and multicast address (multicast and group addresses)
- 32-bit status code for each transmitted or received frame
- Internal FIFOs to buffer transmit and receive frames. The transmit FIFO and the receive FIFO are both 2 Kbytes.
- Supports hardware PTP (precision time protocol) in accordance with IEEE 1588 2008 (PTP V2) with the time stamp comparator connected to the TIM2 input
- Triggers interrupt when system time becomes greater than target time

3.43 High-definition multimedia interface (HDMI) - consumer electronics control (CEC)

The devices embed a HDMI-CEC controller that provides hardware support for the Consumer Electronics Control (CEC) protocol (Supplement 1 to the HDMI standard).

This protocol provides high-level control functions between all audiovisual products in an environment. It is specified to operate at low speeds with minimum processing and memory overhead. It has a clock domain independent from the CPU clock, allowing the HDMI-CEC controller to wakeup the MCU from Stop mode on data reception.

3.44 Debug infrastructure

The devices offer a comprehensive set of debug and trace features to support software development and system integration.

- Breakpoint debugging
- Code execution tracing
- Software instrumentation
- JTAG debug port
- Serial-wire debug port
- Trigger input and output
- Serial-wire trace port
- Trace port
- Arm® CoreSight™ debug and trace components

The debug can be controlled via a JTAG/Serial-wire debug access port, using industry standard debugging tools.

The trace port performs data capture for logging and analysis.

4 Memory mapping

Refer to the product line reference manual for details on the memory mapping as well as the boundary addresses for all peripherals.

Table 7. Legend/abbreviations used in the pinout table

Name		Abbreviation	Definition
Pin name		Unless otherwise specified in brackets below the pin name, the pin function during and after reset is the same as the actual pin name	
Pin type		S	Supply pin
		I	Input only pin
		I/O	Input / output pin
		ANA	Analog-only Input
I/O structure		FT	5 V tolerant I/O
		TT	3.3 V tolerant I/O
		B	Dedicated BOOT0 pin
		RST	Bidirectional reset pin with embedded weak pull-up resistor
		Option for TT and FT I/Os	
		_f	I2C FM+ option
		_a	analog option (supplied by V _{DDA})
		_u	USB option (supplied by V _{DD33USB})
		_h	High Speed Low Voltage
Notes		Unless otherwise specified by a note, all I/Os are set as floating inputs during and after reset.	
Pin functions	Alternate functions	Functions selected through GPIOx_AFR registers	
	Additional functions	Functions directly selected/enabled through peripheral registers	

Table 8. STM32H753xI pin/ball definition (continued)

Pin/ball name								Pin name (function after reset)	Pin type	I/O structure	Notes	Alternate functions	Additional functions
LQFP100	TFBGA100	LQFP144	UFBGA169	UFBGA176+25	LQFP176	LQFP208	TFBGA240 +25						
22	G2	34	J5	N3	40	43	N5 ⁽⁵⁾	PA0	I/O	FT_a	-	TIM2_CH1/TIM2_ETR, TIM5_CH1, TIM8_ETR, TIM15_BKIN, USART2_CTS_NSS, UART4_TX, SDMMC2_CMD, SAI2_SD_B, ETH_MII_CRS, EVENTOUT	ADC1_INP16, WKUP0
-	-	-	-	-	-	-	T1 ⁽⁵⁾	PA0_C	ANA	TT_a	-	-	ADC12_INN1, ADC12_INP0
23	H2	35	K4	N2	41	44	N4 ⁽⁵⁾	PA1	I/O	FT_ha	-	TIM2_CH2, TIM5_CH2, LPTIM3_OUT, TIM15_CH1N, USART2_RTS, UART4_RX, QUADSPI_BK1_IO3, SAI2_MCK_B, ETH_MII_RX_CLK/ETH_RMII_REF_CLK, LCD_R2, EVENTOUT	ADC1_INN16, ADC1_INP17
-	-	-	-	-	-	-	T2 ⁽⁵⁾	PA1_C	ANA	TT_a	-	-	ADC12_INP1
24	J2	36	N1	P2	42	45	N3	PA2	I/O	FT_a	-	TIM2_CH3, TIM5_CH3, LPTIM4_OUT, TIM15_CH1, USART2_TX, SAI2_SCK_B, ETH_MDIO, MDIOS_MDIO, LCD_R1, EVENTOUT	ADC12_INP14, WKUP1
-	-	-	N2	F4	43	46	N2	PH2	I/O	FT_ha	-	LPTIM1_IN2, QUADSPI_BK2_IO0, SAI2_SCK_B, ETH_MII_CRS, FMC_SDCKE0, LCD_R0, EVENTOUT	ADC3_INP13
-	K1	-	M1	-	-	-	F5	VDD	S	-	-	-	-
-	J1	-	M7	J8	-	-	C16	VSS	S	-	-	-	-
-	-	-	M3	G4	44	47	P2	PH3	I/O	FT_ha	-	QUADSPI_BK2_IO1, SAI2_MCK_B, ETH_MII_COL, FMC_SDNE0, LCD_R1, EVENTOUT	ADC3_INN13, ADC3_INP14

Table 8. STM32H753xI pin/ball definition (continued)

Pin/ball name								Pin name (function after reset)	Pin type	I/O structure	Notes	Alternate functions	Additional functions
LQFP100	TFBGA100	LQFP144	UFBGA169	UFBGA176+25	LQFP176	LQFP208	TFBGA240 +25						
97	D4	141	D5	A4	169	200	C4	PE0	I/O	FT_h	-	LPTIM1_ETR, TIM4_ETR, HRTIM_SCIN, LPTIM2_ETR, UART8_RX, FDCAN1_RXFD_MODE, SAI2_MCK_A, FMC_NBL0, DCMI_D2, EVENTOUT	-
98	C4	142	D4	A3	170	201	B4	PE1	I/O	FT_h	-	LPTIM1_IN2, HRTIM_SCOUT, UART8_TX, FDCAN1_TXFD_MODE, FMC_NBL1, DCMI_D3, EVENTOUT	-
-	-	-	-	-	-	-	A7	VCAP	S	-	-	-	-
99	-	-	-	D5	-	202	-	VSS	S	-	-	-	-
-	F7	143	C4	C6	171	203	E7	PDR_ON	S	-	-	-	-
-	F4	-	B4	-	-	-	A6	VDDLDO	S	-	-	-	-
100	-	144	-	C5	172	204	-	VDD	S	-	-	-	-
-	-	-	-	D4	173	205	A4	PI4	I/O	FT_h	-	TIM8_BKIN, SAI2_MCK_A, TIM8_BKIN_COMP12, FMC_NBL2, DCMI_D5, LCD_B4, EVENTOUT	-
-	-	-	-	C4	174	206	A3	PI5	I/O	FT_h	-	TIM8_CH1, SAI2_SCK_A, FMC_NBL3, DCMI_VSYNC, LCD_B5, EVENTOUT	-
-	-	-	A4	C3	175	207	A2	PI6	I/O	FT_h	-	TIM8_CH2, SAI2_SD_A, FMC_D28, DCMI_D6, LCD_B6, EVENTOUT	-
-	-	-	E2	C2	176	208	B3	PI7	I/O	FT_h	-	TIM8_CH3, SAI2_FS_A, FMC_D29, DCMI_D7, LCD_B7, EVENTOUT	-
-	-	-	-	H9	-	-	-	VSS	S	-	-	-	-
-	-	-	-	K9	-	-	-	VSS	S	-	-	-	-
-	-	-	-	K10	-	-	-	VSS	S	-	-	-	-

1. When this pin/ball was previously configured as an oscillator, the oscillator function is kept during and after a reset. This is valid for all resets except for power-on reset.
2. This ball should remain floating.

Table 12. Port D alternate functions

Port		AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
		SYS	TIM1/2/16/17/LPTIM1/HRTIM1	SAI1/TIM3/4/5/12/HRTIM1	LPUART/TIM8/LPTIM2/3/4/5/HRTIM1/DFSDM	I2C1/2/3/4/USART1/TIM15/LPTIM2/DFSDM/CEC	SPI1/2/3/4/5/6/CEC	SPI2/3/SAI1/3/I2C4/UART4/DFSDM	SPI2/3/6/USART1/2/3/6/UART7/SDMMC1	SPI6/SAI2/4/UART4/5/8/LPUART/SDMMC1/SPDIFRX	SAI4/FDCAN1/2/TIM13/14/QUADSPI/FMC/SDMMC2/LCD/SPDIFRX	SAI2/4/TIM8/QUADSPI/SDMMC2/OTG1_HS/OTG2_FS/LCD	I2C4/UART7/SWPMI1/TIM1/8/DFSDM/SDMMC2/MDIOS/ETH	TIM1/8/FMC/SDMMC1/MDIOS/OTG1_FS/LCD	TIM1/DCMI/LCD/COMP	UART5/LCD	SYS
Port D	PD0	-	-	-	DFSDM_CKIN6	-	-	SAI3_SCK_A	-	UART4_RX	FDCAN1_RX	-	-	FMC_D2/FMC_DA2	-	-	EVENT-OUT
	PD1	-	-	-	DFSDM_DATIN6	-	-	SAI3_SD_A	-	UART4_TX	FDCAN1_TX	-	-	FMC_D3/FMC_DA3	-	-	EVENT-OUT
	PD2	TRACED2	-	TIM3_ETR	-	-	-	-	-	UART5_RX	-	-	-	SDMMC1_CMD	DCMI_D11	-	EVENT-OUT
	PD3	-	-	-	DFSDM_CKOUT	-	SPI2_SCK/I2S2_CK	-	USART2_CTS_NSS	-	-	-	-	FMC_CLK	DCMI_D5	LCD_G7	EVENT-OUT
	PD4	-	-	HRTIM_FLT3	-	-	-	SAI3_FS_A	USART2_RTS	-	FDCAN1_RXFD_MODE	-	-	FMC_NOE	-	-	EVENT-OUT
	PD5	-	-	HRTIM_EEV3	-	-	-	-	USART2_TX	-	FDCAN1_TXFD_MODE	-	-	FMC_NWE	-	-	EVENT-OUT
	PD6	-	-	SAI1_D1	DFSDM_CKIN4	DFSDM_DATIN1	SPI3_MOSI/I2S3_SDO	SAI1_SD_A	USART2_RX	SAI4_SD_A	FDCAN2_RXFD_MODE	SAI4_D1	SDMMC2_CK	FMC_NWAIT	DCMI_D10	LCD_B2	EVENT-OUT
	PD7	-	-	-	DFSDM_DATIN4	-	SPI1_MOSI/I2S1_SDO	DFSDM_CKIN1	USART2_CK	-	SPDIFRX_IN0	-	SDMMC2_CMD	FMC_NE1	-	-	EVENT-OUT
	PD8	-	-	-	DFSDM_CKIN3	-	-	SAI3_SCK_B	USART3_TX	-	SPDIFRX_IN1	-	-	FMC_D13/FMC_DA13	-	-	EVENT-OUT
	PD9	-	-	-	DFSDM_DATIN3	-	-	SAI3_SD_B	USART3_RX	-	FDCAN2_RXFD_MODE	-	-	FMC_D14/FMC_DA14	-	-	EVENT-OUT
	PD10	-	-	-	DFSDM_CKOUT	-	-	SAI3_FS_B	USART3_CK	-	FDCAN2_TXFD_MODE	-	-	FMC_D15/FMC_DA15	-	LCD_B3	EVENT-OUT
	PD11	-	-	-	LPTIM2_IN2	I2C4_SMBA	-	-	USART3_CTS_NSS	-	QUADSPI_BK1_IO0	SAI2_SD_A	-	FMC_A16	-	-	EVENT-OUT
	PD12	-	LPTIM1_IN1	TIM4_CH1	LPTIM2_IN1	I2C4_SCL	-	-	USART3_RTS	-	QUADSPI_BK1_IO1	SAI2_FS_A	-	FMC_A17	-	-	EVENT-OUT
	PD13	-	LPTIM1_OUT	TIM4_CH2	-	I2C4_SDA	-	-	-	-	QUADSPI_BK1_IO3	SAI2_SCK_A	-	FMC_A18	-	-	EVENT-OUT
	PD14	-	-	TIM4_CH3	-	-	-	SAI3_MCLK_B	-	UART8_CTS	-	-	-	FMC_D0/FMC_DA0	-	-	EVENT-OUT
	PD15	-	-	TIM4_CH4	-	-	-	SAI3_MCLK_A	-	UART8_RTS	-	-	-	FMC_D1/FMC_DA1	-	-	EVENT-OUT

6 Electrical characteristics

6.1 Parameter conditions

Unless otherwise specified, all voltages are referenced to V_{SS} .

6.1.1 Minimum and maximum values

Unless otherwise specified the minimum and maximum values are guaranteed in the worst conditions of junction temperature, supply voltage and frequencies by tests in production on 100% of the devices with an junction temperature at $T_J = 25\text{ }^{\circ}\text{C}$ and $T_J = T_{Jmax}$ (given by the selected temperature range).

Data based on characterization results, design simulation and/or technology characteristics are indicated in the table footnotes. Based on characterization, the minimum and maximum values refer to sample tests and represent the mean value plus or minus three times the standard deviation ($\text{mean} \pm 3\sigma$).

6.1.2 Typical values

Unless otherwise specified, typical data are based on $T_J = 25\text{ }^{\circ}\text{C}$, $V_{DD} = 3.3\text{ V}$ (for the $1.7\text{ V} \leq V_{DD} \leq 3.6\text{ V}$ voltage range). They are given only as design guidelines and are not tested.

Typical ADC accuracy values are determined by characterization of a batch of samples from a standard diffusion lot over the full temperature range, where 95% of the devices have an error less than or equal to the value indicated ($\text{mean} \pm 2\sigma$).

6.1.3 Typical curves

Unless otherwise specified, all typical curves are given only as design guidelines and are not tested.

6.1.4 Loading capacitor

The loading conditions used for pin parameter measurement are shown in [Figure 12](#).

6.1.5 Pin input voltage

The input voltage measurement on a pin of the device is described in [Figure 13](#).

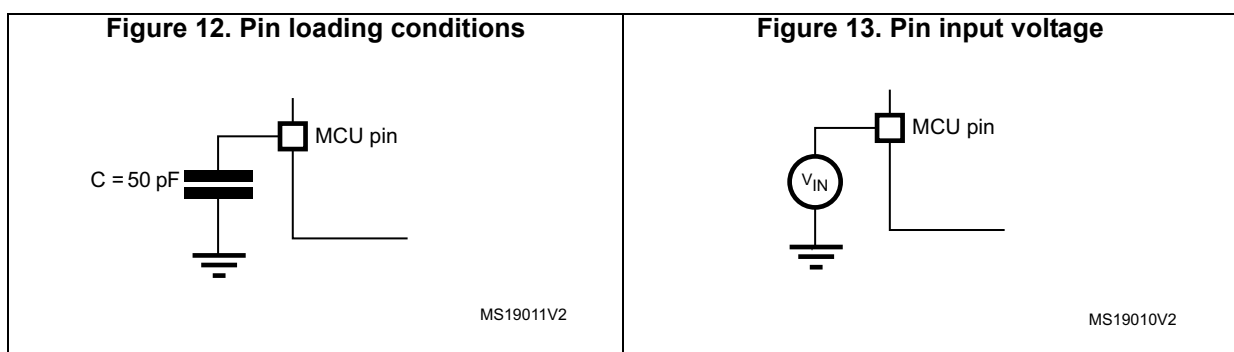


Table 26. Reset and power control block characteristics (continued)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{AVM_0}	Analog voltage detector for V_{DDA} threshold 0	Rising edge	1.66	1.71	1.76	V
		Falling edge	1.56	1.61	1.66	
V_{AVM_1}	Analog voltage detector for V_{DDA} threshold 1	Rising edge	2.06	2.12	2.19	
		Falling edge	1.96	2.02	2.08	
V_{AVM_2}	Analog voltage detector for V_{DDA} threshold 2	Rising edge	2.42	2.50	2.58	
		Falling edge	2.35	2.42	2.49	
V_{AVM_3}	Analog voltage detector for V_{DDA} threshold 3	Rising edge	2.74	2.83	2.91	
		Falling edge	2.64	2.72	2.80	
V_{hyst_VDDA}	Hysteresis of V_{DDA} voltage detector	-	-	100	-	mV
I_{DD_PVM}	PVM consumption from $V_{DD(1)}$	-	-	-	0.25	μ A
I_{DD_VDDA}	Voltage detector consumption on $V_{DDA}^{(1)}$	Resistor bridge	-	-	2.5	μ A

1. Guaranteed by design.

2. BOR0 is enabled in all modes and its consumption is therefore included in the supply current characteristics tables (refer to [Section 6.3.6: Supply current characteristics](#)).

6.3.5 Embedded reference voltage

The parameters given in [Table 27](#) are derived from tests performed under ambient temperature and V_{DD} supply voltage conditions summarized in [Table 23: General operating conditions](#).

Table 27. Embedded reference voltage

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{REFINT}	Internal reference voltages	$-40^{\circ}\text{C} < T_J < 105^{\circ}\text{C}$, $V_{DD} = 3.3\text{ V}$	1.180	1.216	1.255	V
$t_{S_vrefint}^{(1)(2)}$	ADC sampling time when reading the internal reference voltage	-	4.3	-	-	μ s
$t_{S_vbat}^{(1)(2)}$	VBAT sampling time when reading the internal VBAT reference voltage	-	9	-	-	
$I_{refbuf}^{(2)}$	Reference Buffer consumption for ADC	$V_{DDA}=3.3\text{ V}$	9	13.5	23	μ A
$\Delta V_{REFINT}^{(2)}$	Internal reference voltage spread over the temperature range	$-40^{\circ}\text{C} < T_J < 105^{\circ}\text{C}$	-	5	15	mV
$T_{coeff}^{(2)}$	Average temperature coefficient	Average temperature coefficient	-	20	70	ppm/ $^{\circ}\text{C}$
$V_{DDcoeff}^{(2)}$	Average Voltage coefficient	$3.0\text{V} < V_{DD} < 3.6\text{V}$	-	10	1370	ppm/V

Table 38. Peripheral current consumption in Run mode (continued)

Peripheral		I _{DD} (Typ)			Unit
		VOS1	VOS2	VOS3	
APB1 (continued)	UART5 registers	1.4	1.4	1	μA/MHz
	UART5 kernel	3.6	3.2	3.1	
	I2C1 registers	0.8	0.8	0.6	
	I2C1 kernel	2	1.8	1.7	
	I2C2 registers	0.7	0.7	0.4	
	I2C2 kernel	1.9	1.7	1.6	
	I2C3 registers	0.9	0.7	0.6	
	I2C3 kernel	2.1	1.9	1.9	
	HDMI-CEC registers	0.5	0.3	0.3	
	DAC1/2	1.4	1.1	0.9	
	USART7 registers	1.9	1.8	1.3	
	USART7 kernel	4	3.5	3.3	
	USART8 registers	1.6	1.5	1.2	
	USART8 kernel	4	3.6	3.3	
	CRS	3.4	3.1	2.9	
	SWPMI registers	2.3	2	2	
	SWPMI kernel	0.1	0.1	0.1	
	OPAMP	0.5	0.4	0.4	
	MDIO	2.7	2.4	2.3	
	FDCAN registers	16	15	14	
	FDCAN kernel	7.8	7.6	7.1	
	Bridge APB1	0.1	0.1	0.1	

Output buffer timing characteristics (HSLV option enabled)

Table 62. Output timing characteristics (HSLV ON)⁽¹⁾

Speed	Symbol	Parameter	conditions	Min	Max	Unit
00	$F_{\max}^{(2)}$	Maximum frequency	C=50 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	10	MHz
			C=30 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	10	
			C=10 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	10	
	$t_r/t_f^{(3)}$	Output high to low level fall time and output low to high level rise time	C=50 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	11	ns
			C=30 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	9	
			C=10 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	6.6	
01	$F_{\max}^{(2)}$	Maximum frequency	C=50 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	50	MHz
			C=30 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	58	
			C=10 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	66	
	$t_r/t_f^{(3)}$	Output high to low level fall time and output low to high level rise time	C=50 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	6.6	ns
			C=30 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	4.8	
			C=10 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V	-	3	
10	$F_{\max}^{(2)}$	Maximum frequency	C=50 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	55	MHz
			C=30 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	80	
			C=10 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	133	
	$t_r/t_f^{(3)}$	Output high to low level fall time and output low to high level rise time	C=50 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	5.8	ns
			C=30 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	4	
			C=10 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	2.4	
11	$F_{\max}^{(2)}$	Maximum frequency	C=50 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	60	MHz
			C=30 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	90	
			C=10 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	175	
	$t_r/t_f^{(3)}$	Output high to low level fall time and output low to high level rise time	C=50 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	5.3	ns
			C=30 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	3.6	
			C=10 pF, 1.62 V ≤ V _{DD} ≤ 2.7 V ⁽⁴⁾	-	1.9	

1. Guaranteed by design.

2. The maximum frequency is defined with the following conditions:
 $(t_r + t_f) \leq 2/3 T$
 Skew ≤ 1/20 T
 45% < Duty cycle < 55%

3. The fall and rise times are defined between 90% and 10% and between 10% and 90% of the output waveform, respectively.

4. Compensation system enabled.

Table 87. DAC characteristics⁽¹⁾ (continued)

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
$I_{DDA}(DAC)$	DAC quiescent consumption from V_{DDA}	DAC output buffer ON	No load, middle code (0x800)	-	360	-	μA
			No load, worst code (0xF1C)	-	490	-	
		DAC output buffer OFF	No load, middle/worst code (0x800)	-	20	-	
		Sample and Hold mode, $C_{SH}=100\text{ nF}$		-	$360 \cdot T_{ON} / (T_{ON} + T_{OFF})$	-	
$I_{DDV}(DAC)$	DAC consumption from V_{REF+}	DAC output buffer ON	No load, middle code (0x800)	-	170	-	
			No load, worst code (0xF1C)	-	170	-	
		DAC output buffer OFF	No load, middle/worst code (0x800)	-	160	-	
		Sample and Hold mode, Buffer ON, $C_{SH}=100\text{ nF}$ (worst code)		-	$170 \cdot T_{ON} / (T_{ON} + T_{OFF})$	-	
		Sample and Hold mode, Buffer OFF, $C_{SH}=100\text{ nF}$ (worst code)		-	$160 \cdot T_{ON} / (T_{ON} + T_{OFF})$	-	

1. Guaranteed by characterization results.

2. Guaranteed by design.

3. In buffered mode, the output can overshoot above the final value for low input code (starting from the minimum value).

Table 88. DAC accuracy⁽¹⁾

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
DNL	Differential non linearity ⁽²⁾	DAC output buffer ON		-	± 2	-	LSB
		DAC output buffer OFF		-	± 2	-	
INL	Integral non linearity ⁽³⁾	DAC output buffer ON, $C_L \leq 50\text{ pF}$, $R_L \geq 5\text{ k}\Omega$		-	± 4	-	LSB
		DAC output buffer OFF, $C_L \leq 50\text{ pF}$, no R_L		-	± 4	-	
Offset	Offset error at code 0x800 ⁽³⁾	DAC output buffer ON, $C_L \leq 50\text{ pF}$, $R_L \geq 5\text{ k}\Omega$	$V_{REF+} = 3.6\text{ V}$	-	-	± 12	LSB
			$V_{REF+} = 1.8\text{ V}$	-	-	± 25	
		DAC output buffer OFF, $C_L \leq 50\text{ pF}$, no R_L		-	-	± 8	
Offset1	Offset error at code 0x001 ⁽⁴⁾	DAC output buffer OFF, $C_L \leq 50\text{ pF}$, no R_L		-	-	± 5	LSB

Table 96. OPAMP characteristics⁽¹⁾ (continued)

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
V_{OHSAT}	High saturation voltage	$I_{load} = \max$ or $R_{LOAD} = \min^{(2)}$, Input at V_{DDA}		$V_{DDA} - 100 \text{ mV}$	-	-	mV
V_{OLSAT}	Low saturation voltage	$I_{load} = \max$ or $R_{LOAD} = \min^{(2)}$, Input at 0 V		-	-	100	
t_{WAKEUP}	Wake up time from OFF state	Normal mode	$C_{LOAD} \leq 50 \text{ pf}$, $R_{LOAD} \geq 4 \text{ k}\Omega^{(2)}$, follower configuration	-	0.8	3.2	μs
		High speed	$C_{LOAD} \leq 50 \text{ pf}$, $R_{LOAD} \geq 4 \text{ k}\Omega^{(2)}$, follower configuration	-	0.9	2.8	
PGA gain	Non inverting gain value	-		-	2	-	-
		-		-	4	-	-
		-		-	8	-	-
		-		-	16	-	-
	Inverting gain value	-		-	-1	-	-
		-		-	-3	-	-
		-		-	-7	-	-
		-		-	-15	-	-
$R_{network}$	R2/R1 internal resistance values in non-inverting PGA mode ⁽³⁾	PGA Gain=2		-	10/10	-	k Ω / k Ω
		PGA Gain=4		-	30/10	-	
		PGA Gain=8		-	70/10	-	
		PGA Gain=16		-	150/10	-	
	R2/R1 internal resistance values in inverting PGA mode ⁽³⁾	PGA Gain=-1		-	10/10	-	
		PGA Gain=-3		-	30/10	-	
		PGA Gain=-7		-	70/10	-	
		PGA Gain=-15		-	150/10	-	
Delta R	Resistance variation (R1 or R2)	-		-15	-	15	%
PGA BW	PGA bandwidth for different non inverting gain	Gain=2		-	GBW/2	-	MHz
		Gain=4		-	GBW/4	-	
		Gain=8		-	GBW/8	-	
		Gain=16		-	GBW/16	-	

Table 97. DFSDM measured timing 1.62-3.6 V⁽¹⁾ (continued)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{wh(CKIN)}$ $t_{wl(CKIN)}$	Input clock high and low time	SPI mode (SITP[1:0]=0,1), External clock mode (SPICKSEL[1:0]=0), 1.62 < V _{DD} < 3.6 V	TCKIN/2 - 0.5	T _{CKIN} /2	-	ns
t_{su}	Data input setup time	SPI mode (SITP[1:0]=0,1), External clock mode (SPICKSEL[1:0]=0), 1.62 < V _{DD} < 3.6 V	4	-	-	
t_h	Data input hold time	SPI mode (SITP[1:0]=0,1), External clock mode (SPICKSEL[1:0]=0), 1.62 < V _{DD} < 3.6 V	0.5	-	-	
T _{Manchester}	Manchester data period (recovered clock period)	Manchester mode (SITP[1:0]=2,3), Internal clock mode (SPICKSEL[1:0]≠0), 1.62 < V _{DD} < 3.6 V	(CKOUTDIV+1) * T _{DFSDMCLK}	-	(2*CKOUTDIV) * T _{DFSDMCLK}	

1. Guaranteed by characterization results.

Figure 60. Ethernet SMI timing diagram

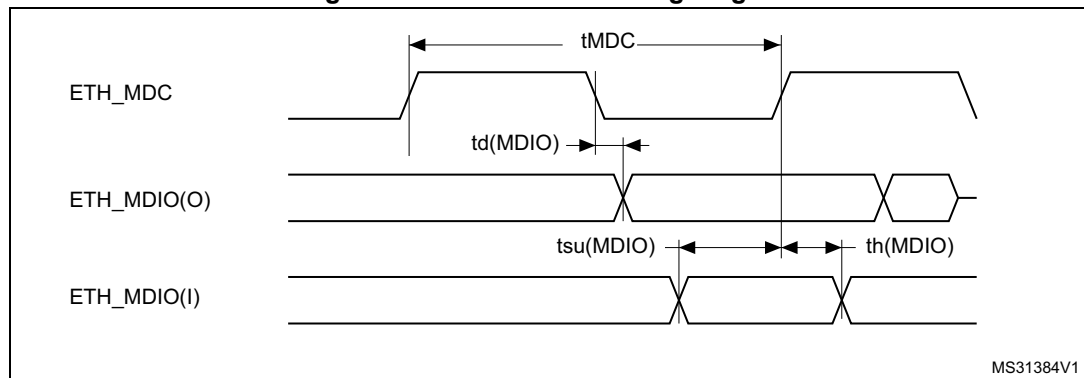


Table 112 gives the list of Ethernet MAC signals for the RMII and Figure 61 shows the corresponding timing diagram.

Table 112. Dynamics characteristics: Ethernet MAC signals for RMII⁽¹⁾

Symbol	Parameter	Min	Typ	Max	Unit
$t_{su}(RXD)$	Receive data setup time	2	-	-	ns
$t_{ih}(RXD)$	Receive data hold time	3	-	-	
$t_{su}(CRS)$	Carrier sense setup time	2.5	-	-	
$t_{ih}(CRS)$	Carrier sense hold time	2	-	-	
$t_d(TXEN)$	Transmit enable valid delay time	4	4.5	7	
$t_d(TXD)$	Transmit data valid delay time	7	7.5	11.5	

1. Guaranteed by characterization results.

Figure 61. Ethernet RMII timing diagram

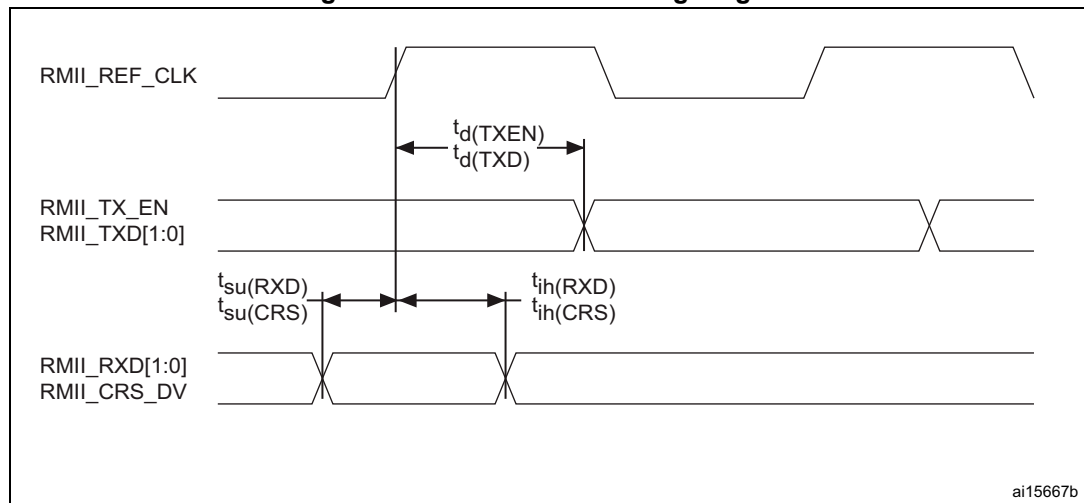


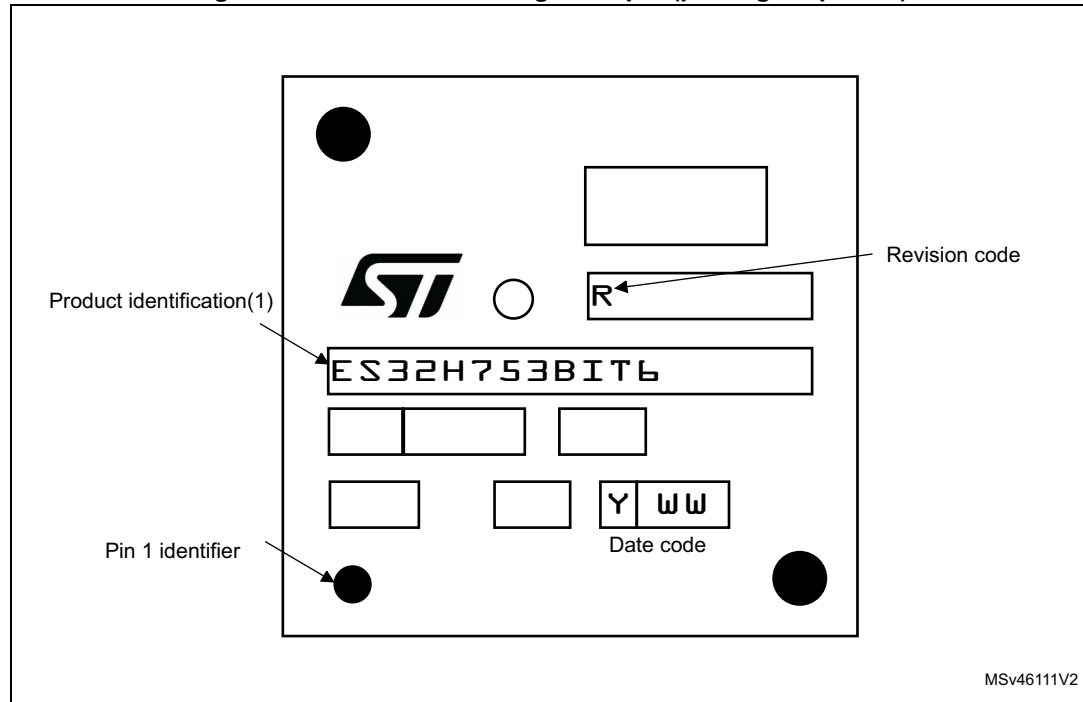
Table 113 gives the list of Ethernet MAC signals for MII and Figure 62 shows the corresponding timing diagram.

Device marking for LQFP208

The following figure gives an example of topside marking versus pin 1 position identifier location.

Other optional marking or inset/upset marks, which depend on supply chain operations, are not indicated below.

Figure 79. LQFP208 marking example (package top view)



1. Parts marked as "ES", "E" or accompanied by an Engineering Sample notification letter, are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.